Self-Protected Low Side Driver with Temperature and Current Limit

42 V, 10 A, Single N-Channel, DPAK

NCV8408 is a single channel protected Low-Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain-to-Gate clamping for overvoltage protection. Thermal protection includes a latch which can be reset by toggling the input. This device is suitable for harsh automotive environments.

Features

- Short Circuit Protection
- Thermal Shutdown with Latched Reset
- Gate Input Current Flag During Latched Fault Condition
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

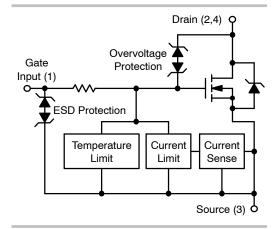
- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

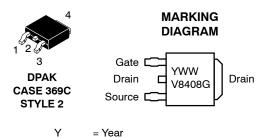


ON Semiconductor®

http://onsemi.com

V _{DSS} (Clamped)	R _{DS(on)} TYP	I _D MAX (Limited)
42 V	55 mΩ @ 5 V	10 A





WW = Work Week
V8408 - Specific Dev

V8408 = Specific Device Code G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV8408DTRKG	DPAK (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped	V _{DSS}	42	Vdc
Drain-to-Gate Voltage Internally Clamped $(R_{GS} = 1.0 \text{ M}\Omega)$	V_{DGR}	42	V
Gate-to-Source Voltage	V _{GS}	±14	Vdc
Continuous Drain Current		Internally Limited	
Total Power Dissipation @ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2)	P _D	1.8 2.3	W
Thermal Resistance Junction-to-Ambient Steady State (Note 1) Junction-to-Ambient Steady State (Note 2) Junction-to-Tab Steady State (Note 3)	$egin{array}{c} R_{ heta JA} \ R_{ heta JA} \ R_{ heta JT} \end{array}$	70 55 2.1	°C/W
Single Pulse Inductive Load Switching Energy $(V_{DD}=20~\text{Vdc}, V_{GS}=5.0~\text{V}, I_L=8.0~\text{A})$ Repetitive Pulse Inductive Load Switching Energy $(V_{DD}=20~\text{Vdc}, V_{GS}=5.0~\text{V}, I_L=8.0~\text{A}, T_J=25^{\circ}\text{C})$	E _{AS} E _{AR}	185 128	mJ
Load Dump Voltage (V _{GS} = 0 and 10 V, R _I = 2.0 Ω , R _L = 4.5 Ω , t _d = 400 ms, T _J = 25 $^{\circ}$ C)	V_{LD}	63	V
Operating Junction Temperature	TJ	-40 to 150	°C
Storage Temperature	T _{stg}	-55 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface-mounted onto minimum pad FR4 PCB (1 oz Cu, 0.06" thick).
 Surface-mounted onto 2" square FR4 PCB, (1" square, 1 oz Cu, 0.06" thick).
 Surface-mounted onto minimum pad FR4 PCB (2 oz Cu, 0.06" thick).

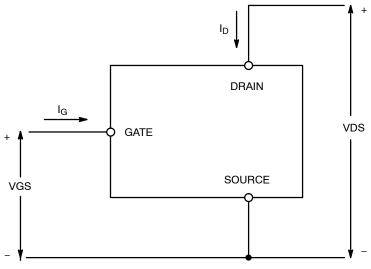


Figure 1. Voltage and Current Convention

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS	I	<u> </u>	1	1	1	1
Drain-to-Source Clamped Breakdown Voltage (Note 4) $ (V_{GS}=0\ V,\ I_D=10\ mA,\ T_J=25^\circ C) $ $ (V_{GS}=0\ V,\ I_D=10\ mA,\ T_J=150^\circ C)\ (Note\ 6) $ $ (V_{GS}=0\ V,\ I_D=10\ mA,\ T_J=-40^\circ C)\ (Note\ 6) $		V _{(BR)DSS}	42 40 43	46 45 47	51 51 51	V
Zero Gate Voltage Drain Current ($V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_J = 25^{\circ}\text{C}$) ($V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_J = 150^{\circ}\text{C}$) (Note	e 6)	I _{DSS}	- -	0.6 2.5	5.0 10	μΑ
INPUT CHARACTERISTICS (Note 4)					_	
Gate Input Current - Normal Operation	(V _{GS} = 5.0 V)	I _{GSSF}	_	25	50	μΑ
Gate Input Current - Protection Latched	(V _{GS} = 5.0 V) (Note 6)	I _{GSSL}	-	440	-	μА
Gate Threshold Voltage	$(V_{GS} = V_{DS}, I_D = 1 \text{ mA})$	V _{GS(th)}	1.0	1.7	2.2	V
Gate Threshold Temperature Coefficient		V _{GS(th)} /T _J	-	5.0	-	-mV/°C
Latched Reset Voltage	(Note 6)	V_{LR}	0.8	1.4	1.9	V
Latched Reset Time	(V _{GS} = 5.0 V to V _{GS} < 1 V) (Note 6)	t _{LR}	10	40	100	μs
Internal Gate Input Resistance			-	25.5	-	kΩ
ON CHARACTERISTICS (Note 4)						•
Static Drain-to-Source On-Resistance (V _{GS} = 5.0 V, I _D = 3.0 A, T _J @ 25°C) (V _{GS} = 5.0 V, I _D = 3.0 A, T _J @ 150°C) (Note 6)		R _{DS(on)}	_ _	55 100	60 120	mΩ
Source-Drain Forward On Voltage	(V _{GS} = 0 V, I _S = 7.0 A)	V _{SD}	_	0.95	_	V
SWITCHING CHARACTERISTICS (Note	6)		Į			
Turn-ON Delay Time		t _{d(ON)}		10	20	μs
Rise Time (10% I _D to 90% I _D)		t _r		20	40	- '
Turn-OFF Delay Time	V _{GS} = 5 V. V _{DS} = 13 V	t _{d(OFF)}		30	60	1
Fall Time (90% I _D to 10% I _D)	$V_{GS} = 5 \text{ V}, V_{DS} = 13 \text{ V}$ $R_L = 4 \Omega, -40^{\circ}\text{C} < T_J < 150^{\circ}\text{C}$	t _f		20	40	1
Slew-Rate ON (90% V _D to 10% V _D)		-dV _{DS} /dt _{ON}		0.5		V/µs
Slew-Rate OFF (10% V _D to 90% V _D)		dV _{DS} /dt _{OFF}		0.5		
SELF PROTECTION CHARACTERISTICS	$S (T_1 = 25^{\circ}C \text{ unless otherwise noted}) (N)$	Note 5)	ı			
Current Limit $V_{GS} = 5.0 \text{ V}, V_{DS} = 10 \text{ V}, T_J @ 25^{\circ}\text{C}$ $V_{GS} = 5.0 \text{ V}, V_{DS} = 10 \text{ V}, T_J = 150^{\circ}\text{C}$ (Not $V_{GS} = 5.0 \text{ V}, V_{DS} = 10 \text{ V}, T_J = -40^{\circ}\text{C}$ (Not	re 6)	I _{LIM}	9 10 10	13 - -	16 18 16	A
Temperature Limit (Turn-off)	V _{GS} = 5.0 V V _{GS} = 10 V	T _{LIM(off)}	150 150	175 165	200 185	°C
ESD ELECTRICAL CHARACTERISTICS	(T _J = 25°C unless otherwise noted)					-
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000	_	-	V
Electro-Static Discharge Capability	Machine Model (MM)	ESD	400	-	-	V
			·			

Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.
 Fault conditions are viewed as beyond the normal operating range of the part.
 Not subject to production testing.

TEST CIRCUITS AND WAVEFORMS

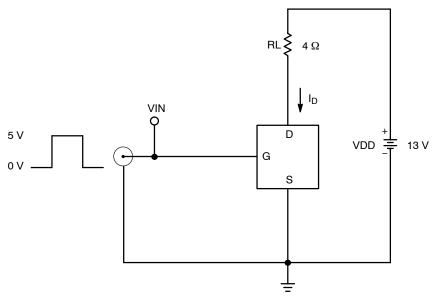


Figure 2. Resistive Load Switching Test Circuit

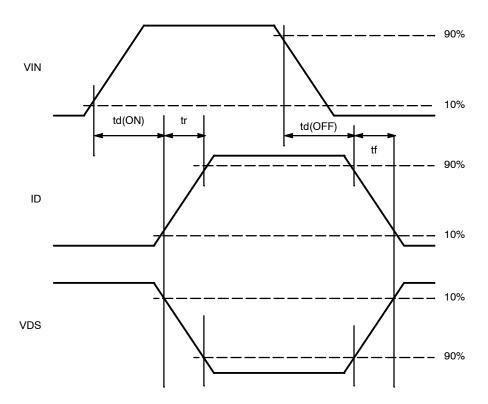


Figure 3. Resistive Load Switching Waveforms

TEST CIRCUITS AND WAVEFORMS

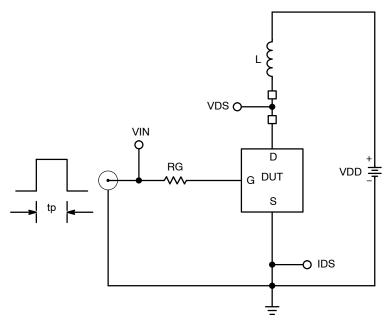


Figure 4. Inductive Load Switching Test Circuit

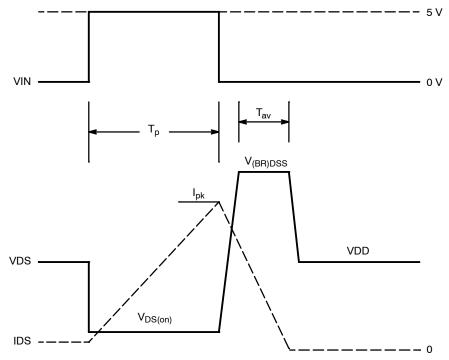


Figure 5. Inductive Load Switching Waveforms

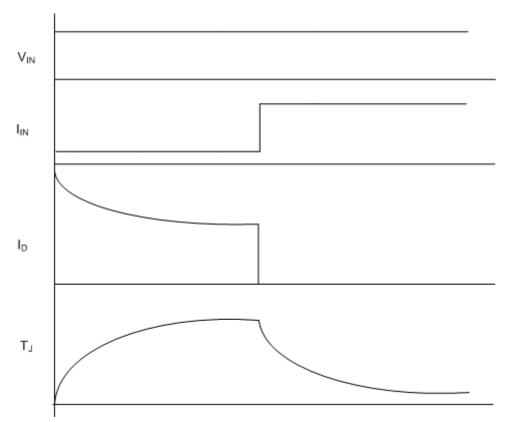


Figure 6. Short-Circuit Protection Behaviour

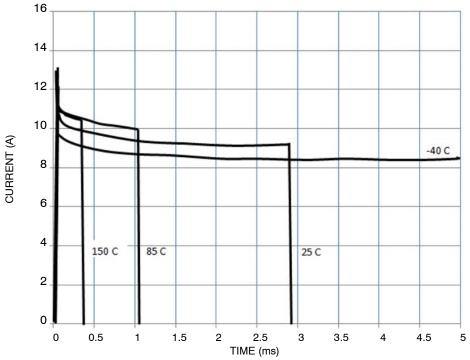
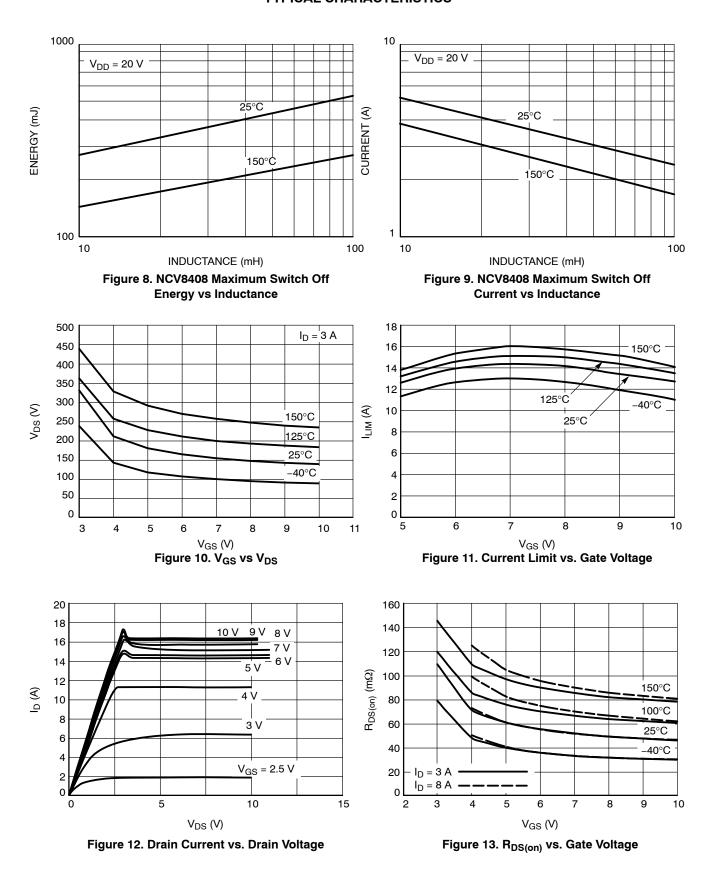


Figure 7. Turn on into Short Circuit Device Response

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

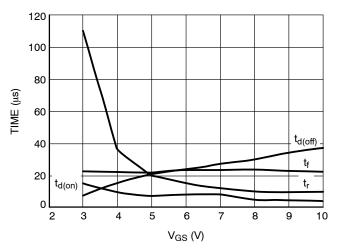


Figure 14. Resistive Switching

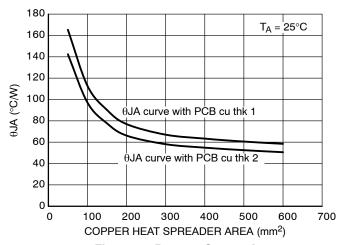


Figure 15. $R_{\theta JA}$ vs. Copper Area

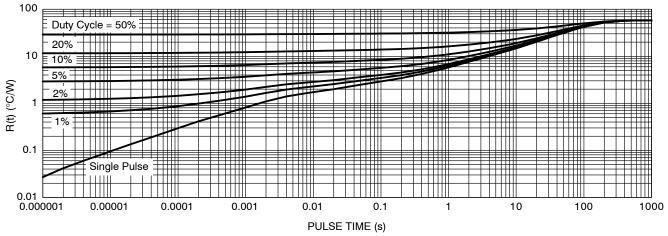
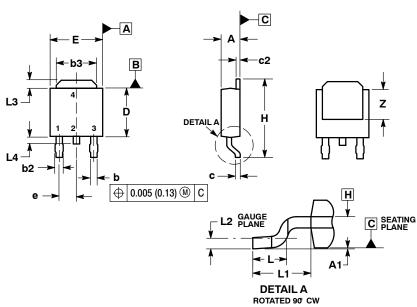


Figure 16. Transient Thermal Resistance

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369C ISSUE D



NOTES:

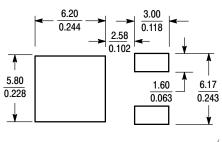
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A 1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN

3. SOURCE DRAIN

SOLDERING FOOTPRINT*



mm SCALE 3:1

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^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.